



Specification for Approval

Date: 2024/05/24

Customer: 深圳臺慶

	TAI-TECH P/N:	HSF1210F2SF-900						
	CUSTOMER P/N:							
•	DESCRIPTION:							
	QUANTITY:	pcs	<u>; </u>					
REM	IARK:							
	Cu	stomer Approval Feedba	nck					

■ 西北臺慶科技股份有限公司

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Peter Tzou	Zhi-Hong Lin	Michelle Lim

Wire Wound Type Common Mode Filter

HSF1210F2SF-900

	ECN HISTORY LIST							
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN			
1.0	24/05/24	新 發 行	鄒俊德	林志鴻	林靜婷			
/ -11-								
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Wire Wound Type Common Mode Filter

HSF1210F2SF-900

1. Features

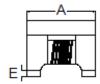
1. High common mode impedance at high frequency cause excellent noise suppression performance.

- 2. HSF1210F2SF series realizes small size and low profile. 1.2x1.0x0.9 mm.
- 3. 100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 4. Excellent for USB3.0

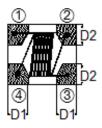




2. Dimension

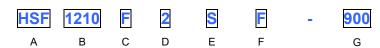






Series	A(mm)	B(mm)	C(mm)	D1(mm)	D2(mm)	E(mm)
1210F2SF	1.2±0.2	1.0±0.2	0.9 max.	0.35±0.1	0.35±0.1	0.03 min.

3. Part Numbering



A: Series

B: Dimension

C: Material Ferrite
D: Number of Lines 2=2 lines

E: Type S=Shielded, N=Unshielded

F: Lead free

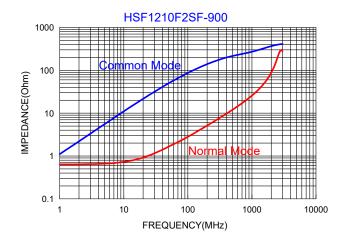
G: Impedance $900=90 \Omega$

4. Specification

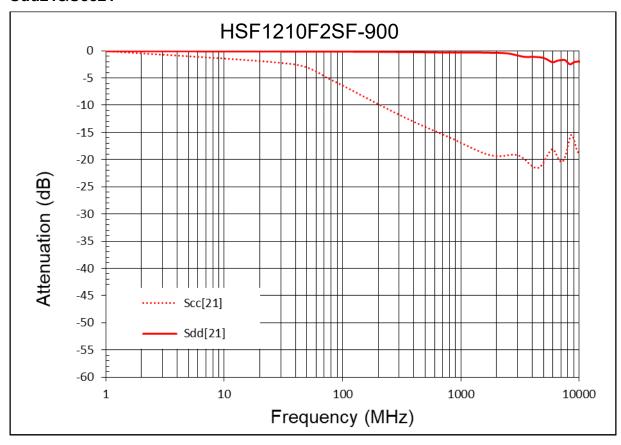
TAI-TECH Part Number	Common mode Impedance (Ω)	Test Frequency (MHz)	DC Resistance (Ω) max.	Rated Current (mA) max.	Rated Volt. (Vdc) max.	Withstand Volt. (Vdc) max.	IR (Ω) min.
HSF1210F2SF-900	90±25%	100	0.40	200	50	125	10M

Note:

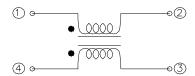
● All test data referenced to 25°C ambient.



Sdd21&Scc21

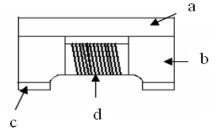


5. Schematic Diagram



6. Materials

No.	Description	Specification
a.	Upper Plate	Ferrite
b.	Core	Ferrite Core
С	Termination	Ag/Ni/Sn
d	Wire	Enameled Copper Wire



7. Reliability and Test Condition

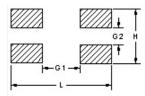
Item	Performance	Test Condition
Operating temperature	-40~+125℃ (Including self - temperature rise)	
Storage temperature	-40~+125℃ (on board)	
Electrical Performance Tes	st	
Z(common mode)		Keysight E4991B + Keysight 16197A
DCR	Refer to standard electrical characteristics list.	Agilent-34420A Agilent-4338B
l.R.		Chroma 19073
Withstand Volt	Test Voltage : Rated Voltage*2.5 times. Time : 1 ~ 5 s. Charge Current : 1 mA max.	Chroma 19073
Temperature Rise Test	Rated Current ΔT 40°C Max	1.Applied the allowed DC current. 2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test		Preconditioning: Run through reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) Temperature: 125±2°C Applied current: rated current Duration: 1000±12hrs Measured at room temperature after placing for 24 hrs.
Load Humidity		Preconditioning: Run through reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) Humidity: 85±3% R.H, Temperature: 85°C±2°C Duration: 1000hrs Min. Bead: with 100% rated current Inductance: with 10% rated current Measured at room temperature after placing for 24 hrs.
Moisture Resistance	Appearance: No damage. Impedance: within±15% of initial value RDC: within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) 1. Baked at 50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep hours, cool down to 25°C in 2.5hrs, keep at 25°C for 2hrs then keep at -10°C for 3hrs. 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measured at room temperature after placing for 1-2 hrs.
Thermal Shock Vibration		Preconditioning: Run through reflow for 3 times. (IPC/JEDEC J-STD-020E Classification Reflow Profiles) Condition for 1 cycle Step1: -40±2°C 30±5min Step2: 125±2°C ≦0.5min Step3: 125±2°C 30±5min Number of cycles: 500 Measured at room temperature after placing for 24 hrs. Preconditioning: Run through reflow for 3 times. (IPC/JEDEC J-STD-020E Classification Reflow Profiles) Oscillation Frequency: 10Hz~2kHz~10Hz for 20 minutes Equipment: Vibration checker

Item	Performance	Test Condition					
Bending	Appearance : No damage. Impedance : within±15% of initial value	Shall be mounted on a FR4 substrate of the followin >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.			ving dimensions:		
Objects	RDC : within±15% of initial value and shall not exceed the specification value		Туре	Peak value (g's)	Normal duration (D) (ms)	torm	Velocity change (Vi)ft/sec
Shock			SMD Lead	50	11	Half-sine Half-sine	11.3
		3 sh	ocks in	each direc	tion along 3 pe	erpendicular a	exes. (18 shocks).
Solderability	More than 95% of the terminal electrode should be covered with solder	a. Method B, 4hrs @155°C dry heat @235°C±5°C Testing Time :5 +0/-0.5 seconds b. Method D category 3. (8hours ± 15 min)@ 260°C±5°C Testing Time :30 +0/-0.5 seconds					
Resistance to Soldering Heat			Temp	erature(°C) 260 ±5 der temp)	Time(s) rar and 10 ±1 25r	emperature mp/immersion emersion rat nm/s ±6 mm/	e heat cycles
	Appearance: No damage. Impedance: within±15% of initial value RDC: within±15% of initial value and shall not exceed the specification value	(IP(With appl bein force	C/JEDE the co y a for g teste e shall	C J-STD-0 mponent m ce (>0805) d. This force	:1kg,<=0805 e shall be app d gradually as	tion Reflow P CB with the o :0.3kg) to the lied for 60 +1	rofiles) levice to be tested, e side of a device seconds. Also the ly a shock to the
Terminal Strength			sı	DUT	pre	ss tool	wide

8. Soldering and Mounting

8-1. Recommended PC Board Pattern

	HSF1210F2S
L(mm)	1.55
H(mm)	1.10
G1(mm	0.65
G2(mm	0.30



8-2. Soldering

Mildly activated rosin fluxes are preferred. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

8-2.1 Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

8-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Figure 2.)

- Preheat circuit and products to 150°C
 350°C tip temperature (max)
- Never contact the ceramic with the iron tip
 1.0mm tip diameter (max)
- ${\boldsymbol{\cdot}}$ Use a 20 watt soldering iron with tip diameter of 1.0mm
- Limit soldering time to 4~5sec.

Fig.1 Soldering Reflow

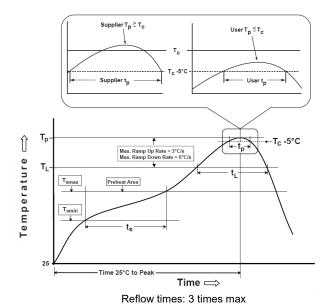
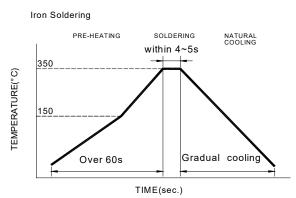


Fig.2 Iron soldering temperature profiles



Iron Soldering times: 1 times max

Table (1.1): Reflow Profiles

Profile Type:	Pb-Free Assembly
Preheat -Temperature Min(T _{smin}) -Temperature Max(T _{smax}) -Time(t _s)from(T _{smin} to T _{smax})	150°C 200°C 60-120seconds
Ramp-up rate(T_L to T_p)	3°C/second max.
$\label{eq:Liquidus} \begin{array}{c} \text{Liquidus temperature}(T_L) \\ \text{Time}(t_L) \text{maintained above } T_L \end{array}$	217°C 60-150 seconds
Classification temperature(T _c)	See Table (1.2)
$\label{eq:total_power} \mbox{Time}(t_p) \mbox{ at Tc-} \mbox{ 5}^{\circ} \mbox{$^{\circ}$} \mbox{ (Tp should be equal to or less than Tc.)}$	< 30 seconds
Ramp-down rate(T _p to T _L)	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

Tp: maximum peak package body temperature, Tc: the classification temperature.

For user (customer) Tp should be equal to or less than Tc.

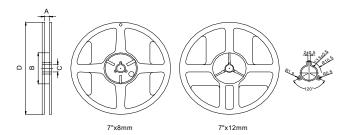
Table (1.2) Package Thickness/Volume and Classification Temperature (T_c)

	Package	Volume mm ³	Volume mm ³	Volume mm ³
	Thickness	<350	350-2000	>2000
	<1.6mm	260°C	260°C	260°C
PB-Free Assembly	1.6-2.5mm	260°C	250°C	245°C
	≥2.5mm	250°C	245°C	245°C

Reflow is referred to standard IPC/JEDEC J-STD-020E ∘

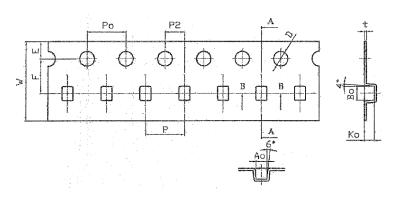
9. Packaging Information

9-1. Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60.0±2.0	13.5±0.5	178.0±2.0

9-2. Tape Dimension / 8mm

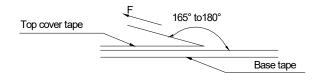


Series	W(mm)	P(mm)	E(mm)	F(mm)	P2(mm)	D(mm)	P0(mm)	A0(mm)	B0(mm)	K0(mm)	t(mm)
HSF1210F2S	8.00±0.10	4.00±0.10	1.75±0.10	3.50±0.05	2.00±0.05	1.50+0.10/-0.00	4.00±0.10	1.12±0.10	1.40±0.10	1.05±0.10	0.22±0.05

9-3. Packaging Quantity

Chip size	Chip/Reel	Inner Box	Middle Box	Carton
HSF1210F2S	3000	15000	75000	150000

9-4. Tearing Off Force



The force for tearing off cover tape is 15 to 80 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

- Storage Conditions(component level)
- To maintain the solderability of terminal electrodes:
- 1. TAI-TECH products meet IPC/JEDEC J-STD-020E standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than $40^\circ\!\!\!\!\!\mathrm{C}^{}$ and 60% RH.
- 3. Recommended products should be used within 12 months from the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
 - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
 - 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
 - 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



Test Report

號碼(No.): ETR24301725

日期(Date): 15-Mar-2024

頁數(Page): 1 of 16

西北臺慶科技股份有限公司 (TAI-TECH ADVANCED ELECTRONICS CO., LTD.)

臺慶精密電子(昆山)有限公司 (TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO., LTD.)

慶邦電子元器件 (泗洪) 有限公司 (TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

桃園市楊梅區幼獅工業區幼四路1號 (NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN R. O. C.)

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以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by the applicant as):

樣品名稱(Sample Name)

WIREWOUND SERIES

樣品型號(Style/Item No.)

WCM(YCW · FWCM · SWCM) · WCL · HSF · HDMI · DVI · BCM · PCM · TCM · LCM · LPF · TXF · ACM(FACM · SACM) · DCM(YLW · SDCM) · WIH · BPH · TNH · YCM · STF · APO · QLL · FGO · APOC · TLAN · SIF · DWC ·

DWCD · WCMD · DCMD SERIES

收件日(Sample Receiving Date)

08-Mar-2024

測試期間(Testing Period)

08-Mar-2024 to 15-Mar-2024

測試需求(Test Requested)

依據客戶要求進行測試‧測試項目請參閱測試結果表格。 (Testing item(s) is/are

specified by client. Please refer to result table for testing item(s).)

測試結果(Test Results)

請參閱下一頁 (Please refer to following pages.)

Signed for and on behalf SGS TAIWAN LTD. Chemical Laboratory - Taipei



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測試部位敘述 (Test Part Description)

No 1

整體混測 (MIXED ALL PARTS)

測試結果 (Test Results)

測試項目 (Test Items)	測試方法 (Method)	單位 (Unit)	MDL	結果 (Result)
,				No.1
鎘 (Cd) (Cadmium (Cd))	參考IEC 62321-5: 2013·以感應耦合電漿發射光譜儀分析。(With reference to IEC	mg/kg	2	n.d.
鉛 (Pb) (Lead (Pb))	62321-5: 2013, analysis was performed by ICP-OES.)	mg/kg	2	n.d.
汞 (Hg) (Mercury (Hg))	参考IEC 62321-4: 2013+ AMD1: 2017·以 感應耦合電漿發射光譜儀分析。(With reference to IEC 62321-4: 2013+ AMD1: 2017, analysis was performed by ICP-OES.)	mg/kg	2	n.d.
六價鉻 Cr(VI) (Hexavalent Chromium Cr(VI))	參考IEC 62321-7-2: 2017,以紫外光-可見光 分光光度計分析。(With reference to IEC 62321-7-2: 2017, analysis was performed by UV-VIS.)	mg/kg	8	n.d.
一溴聯苯 (Monobromobiphenyl)		mg/kg	5	n.d.
二溴聯苯 (Dibromobiphenyl)		mg/kg	5	n.d.
三溴聯苯 (Tribromobiphenyl)	Ī !	mg/kg	5	n.d.
四溴聯苯 (Tetrabromobiphenyl)	Ī	mg/kg	5	n.d.
五溴聯苯 (Pentabromobiphenyl)	参考IEC 62321-6: 2015,以氣相層析儀/質譜	mg/kg	5	n.d.
六溴聯苯 (Hexabromobiphenyl)	儀分析。(With reference to IEC 62321-6:	mg/kg	5	n.d.
七溴聯苯 (Heptabromobiphenyl)	2015, analysis was performed by GC/MS.)	mg/kg	5	n.d.
八溴聯苯 (Octabromobiphenyl)]	mg/kg	5	n.d.
九溴聯苯 (Nonabromobiphenyl)] . [mg/kg	5	n.d.
十溴聯苯 (Decabromobiphenyl)]	mg/kg	5	n.d.
多溴聯苯總和 (Sum of PBBs)		mg/kg	_	n.d.

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測試項目	測試方法	單位	MDL	結果
(Test Items)	(Method)	(Unit)		(Result)
				No.1
一溴聯苯醚 (Monobromodiphenyl ether)		mg/kg	5	n.d.
二溴聯苯醚 (Dibromodiphenyl ether)		mg/kg	5	n.d.
三溴聯苯醚 (Tribromodiphenyl ether)		mg/kg	5	n.d.
四溴聯苯醚 (Tetrabromodiphenyl ether)		mg/kg	5	n.d.
五溴聯苯醚 (Pentabromodiphenyl ether)	参考IEC 62321-6: 2015 · 以氣相層析儀/質譜	mg/kg	5	n.d.
六溴聯苯醚 (Hexabromodiphenyl ether)	儀分析。(With reference to IEC 62321-6:	mg/kg	. 5	n.d.
七溴聯苯醚 (Heptabromodiphenyl ether)	2015, analysis was performed by GC/MS.)	mg/kg	5	n.d.
八溴聯苯醚 (Octabromodiphenyl ether)		mg/kg	5	n.d.
九溴聯苯醚 (Nonabromodiphenyl ether)		mg/kg	5	n.d.
十溴聯苯醚 (Decabromodiphenyl ether)		mg/kg	5	n.d.
多溴聯苯醚總和 (Sum of PBDEs)	1	mg/kg	-	n.d.
鄰苯二甲酸丁苯甲酯 (BBP) (Butyl benzyl		mg/kg	50	n.d.
phthalate (BBP))				
鄰苯二甲酸二丁酯 (DBP) (Dibutyl		mg/kg	50	n.d.
phthalate (DBP))				
鄰苯二甲酸二(2-乙基己基)酯 (DEHP) (Di-		mg/kg	50	n.d.
(2-ethylhexyl) phthalate (DEHP))	 參考IEC 62321-8: 2017,以氣相層析儀/質譜			
鄰苯二甲酸二異丁酯 (DIBP) (Diisobutyl	参考IEC 02321-8. 2017,以無相層が展/真晶 儀分析。(With reference to IEC 62321-8:	mg/kg	50	n.d.
phthalate (DIBP))	2017, analysis was performed by GC/MS.)			
鄰苯二甲酸二異癸酯 (DIDP) (Diisodecyl	2017, analysis was performed by GC/1913.7	mg/kg	50	n.d.
phthalate (DIDP)) (CAS No.: 26761-40-				
0, 68515-49-1)				
鄰苯二甲酸二異壬酯 (DINP) (Diisononyl		mg/kg	50	n.d.
phthalate (DINP)) (CAS No.: 28553-12-				
0, 68515-48-0)				

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測試項目 (Test Items)	測試方法 (Method)	單位 (Unit)	MDL	結果 (Result) No.1
鄰苯二甲酸二正辛酯 (DNOP) (Di-n-octyl phthalate (DNOP)) (CAS No.: 117-84-0)		mg/kg	50	n.d.
鄰苯二甲酸二正戊酯 (DNPP) (Di-n-pentyl phthalate (DNPP)) (CAS No.: 131-18-0)	参考IEC 62321-8: 2017・以氣相層析儀/質譜 儀分析・(With reference to IEC 62321-8: 2017, analysis was performed by GC/MS.)	mg/kg	50	n.d.
鄭苯二甲酸二正己酯 (DNHP) (Di-n-hexyl phthalate (DNHP)) (CAS No.: 84-75-3)		mg/kg	50	n.d.
六溴環十二烷及所有主要被辨別出的異構物(HBCDD) (α - HBCDD, β - HBCDD, γ - HBCDD) (Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α - HBCDD, β - HBCDD, γ - HBCDD)) (CAS No.: 25637-99-4, 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	參考IEC 62321-9: 2021,以氣相層析儀/質譜 儀分析。(With reference to IEC 62321-9: 2021, analysis was performed by GC/MS.)	mg/kg	20	n.d.
氟 (F) (Fluorine (F)) (CAS No.: 14762-94-8)		mg/kg	50	n.d.
氯 (CI) (Chlorine (CI)) (CAS No.: 22537- 15-1)	参考BS EN 14582: 2016・以離子層析儀分 析。(With reference to BS EN 14582: 2016, ;	mg/kg	50	n.d.
溴 (Br) (Bromine (Br)) (CAS No.: 10097- 32-2)	analysis was performed by IC.)	mg/kg	50	n.d.
碘 (I) (Iodine (I)) (CAS No.: 14362-44-8)		mg/kg	50	n.d.
全氟辛烷磺酸及其鹽類 (PFOS and its salts) (CAS No.: 1763-23-1 and its salts)	参考CEN/TS 15968: 2010,以液相層析串聯 質譜儀分析。(With reference to CEN/TS	mg/kg	0.01	n.d.
全氟辛酸及其鹽類 (PFOA and its salts) (CAS No.: 335-67-1 and its salts)	15968: 2010, analysis was performed by LC/MS/MS.)	mg/kg	0.01	n.d.

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測試項目 (Test Items)	測試方法 (Method)	單位 (Unit)	MDL	結果 (Result) No.1
聚氯乙烯 (Polyvinyl chloride) (PVC)	參考ASTM E1252: 2021 · 以傅立葉轉換紅外線光譜儀及焰色法分析。(With reference to ASTM E1252: 2021, analysis was performed by FT-IR and Flame Test.)	**	_	Negative
銻 (Sb) (Antimony (Sb)) (CAS No.: 7440-36-0)	參考US EPA 3052: 1996 · 以感應耦合電漿發射光譜儀分析。(With reference to US EPA	mg/kg	2	n.d.
鈹 (Be) (Beryllium (Be)) (CAS No.: 7440- 41-7)	3052: 1996, analysis was performed by ICP-OES.)	mg/kg	2	n.d.

備註(Note):

- 1. mg/kg = ppm; 0.1wt% = 0.1% = 1000ppm
- 2. MDL = Method Detection Limit (方法偵測極限值)
- 3. n.d. = Not Detected (未檢出); 小於MDL / Less than MDL
- 4. "-" = Not Regulated (無規格值)
- 5. **= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到/未檢出); Positive = Detectable 陽性(已偵測到/檢出)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量。
 The sample(s) was/were analyzed on behalf of the applicant as mixing sample in one testing. The above result(s) was/were only given as the informality value.

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PFAS Remark:

現有PFAS定量技術是分析PFAS物質的特定結構,但同碳數族群之PFAS酸及鹽類物質,其可被辨識的特定結構相同,因此無法區別所分析的特定結構是來自酸或者鹽類,故測試結果為同碳數族群之PFAS之酸及鹽類物質的濃度總合。下表PFAS物質濃度皆已包含在測試結果中,相關資訊請參見下表:(下表列舉PFAS物質僅為範例,並不包含所有同碳數族群之PFAS鹽類。)

(The quantitative technology of PFAS is to analyze the specific structure of PFAS substances. However, PFAS acid and its salts with the same carbon number group have the same specific structure that can be identified. The tested results of the analyzed specific structure cannot be distinguished to identify the contribution from PFAS acid or its salts. Therefore, the tested results display the sum of concentrations of PFAS acids and its salts with the same carbon number group. The concentration of PFAS substances in the below table have been included in the tested results, please refer to the table for relevant information: (The listed PFAS substances are examples only, it do not include all PFAS salts with the same carbon number group.))

群組名稱 (Group Name)	物質名稱 (Substance Name)	CAS No.
	全氟辛烷磺酸 (Perfluorooctane sulfonates) (PFOS) 全氟辛基磺酸鉀 (PFOS-K) Potassium perfluorooctanesulfonate (PFOS-K)	1763-23-1 2795-39-3
	全氟辛基磺酸鋰 (PFOS-Li) Perfluorooctanesulfonic acid, lithium salt (PFOS-Li)	29457-72-5
	全氟辛基磺酸銨 (PFOS-NH ₄) Perfluorooctanesulfonic acid, ammonium salt (PFOS-NH ₄)	29081-56-9
PFOS, 及其鹽&衍生物 (PFOS, its salts & derivatives)	全氟辛基磺酸二乙醇銨 (PFOS-NH(OH) ₂) Perfluorooctane sulfonate diethanolamine salt (PFOS-NH(OH) ₂)	70225-14-8
	全氣辛基磺酸四乙基銨 (PFOS-N(C_2H_5) $_4$) Perfluorooctanesulfonic acid,tetraethylammonium salt (PFOS-N(C_2H_5) $_4$)	56773-42-3
	全氣辛基磺酸二癸二甲基鈹 (PFOS-DDA) N-decyl-N,N-dimethyldecan-1-aminium 1,1,2,2,3,3,4,4,5,5,6,6,7,7,8,8,8-heptadecafluorooctane-1- sulfonate (PFOS-DDA)	251099-16-8

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群組名稱 (Group Name)	物質名稱 (Substance Name)	CAS No.
	全氟辛基磺醯氟 (POSF) Perfluorooctane sulfonyl fluoride (POSF)	307-35-7
	全氟辛基磺酸鎂 (PFOS-Mg) Perfluorooctanesulfonic acid, magnesium salt (PFOS-Mg)	91036-71-4
PFOS, 及其鹽&衍生物 (PFOS, its salts & derivatives)	全氟辛基磺酸鈉 (PFOS-Na) Perfluorooctanesulfonic acid, sodium salt (PFOS-Na)	4021-47-0
	全氟辛烷磺酸哌啶 Piperidine 1,1,2,2,3,3,4,4,5,5,6,6,7,7,8,8,8,- heptadecafluorooctanesulfonate	71463-74-6
	全氟辛酸 (Perfluorooctanoic acid) (PFOA)	335-67-1
	全氟辛酸鈉 (PFOA-Na) Sodium perfluorooctanoate (PFOA-Na)	335-95-5
	全氟辛酸鉀 (PFOA-K) Potassium perfluorooctanoate (PFOA-K)	2395-00-8
PFOA, 及其鹽&衍生物	全氟辛酸銀 (PFOA-Ag) Silver perfluorooctanote (PFOA-Ag)	335-93-3
(PFOA, its salts & derivatives)	全氟辛氟 (PFOA-F) Perfluorooctanoyl fluoride (PFOA-F)	335-66-0
	全氟辛酸銨 (APFO) Ammonium pentadecafluorooctanoate (APFO)	3825-26-1
	全氟辛酸鋰 (PFOA-Li) Lithium perfluorooctanoate (PFOA-Li)	17125-58-5

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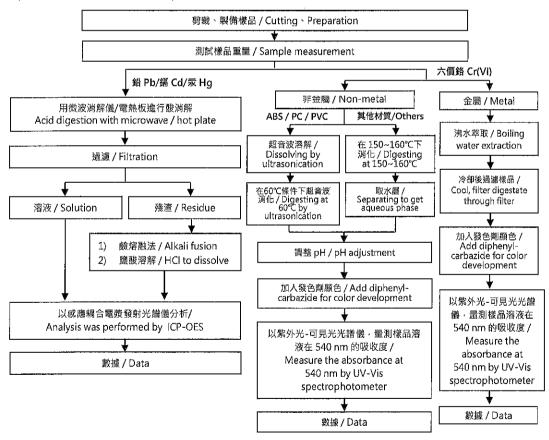
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重金屬流程圖 / Analytical flow chart of heavy metal

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外)

These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr^{6+} test method excluded)



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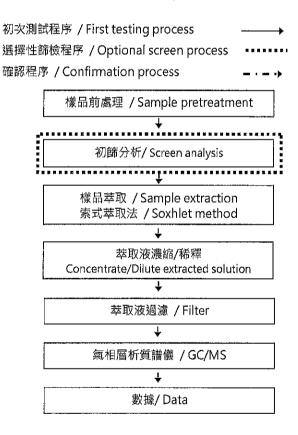
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多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBBs/PBDEs



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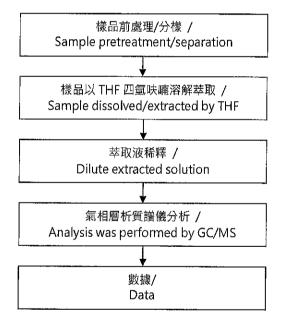
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可塑劑分析流程圖 / Analytical flow chart - Phthalate

【測試方法/Test method: IEC 62321-8】



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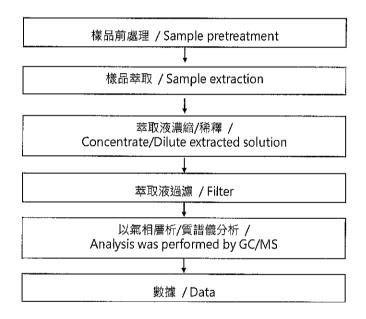
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六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD



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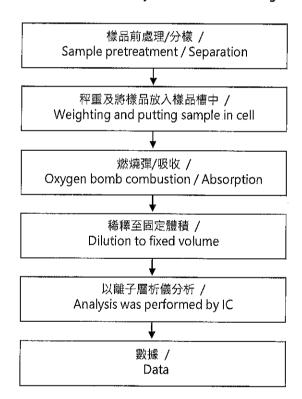
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鹵素分析流程圖 / Analytical flow chart - Halogen



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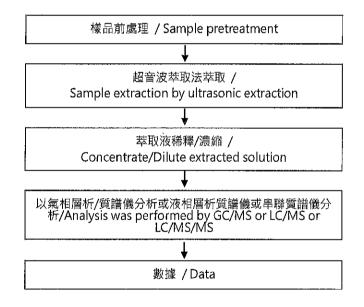
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全氟化合物(包含全氟辛酸/全氟辛烷磺酸/其相關化合物等等)分析流程圖 / Analytical flow chart – PFAS (including PFOA/PFOS/its related compound, etc.)



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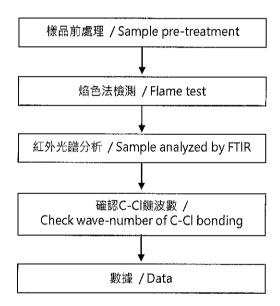
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聚氯乙烯物質判定分析流程圖 / Analysis flow chart - PVC



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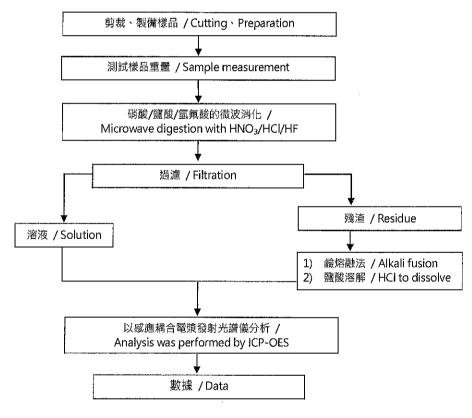
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元素(含重金屬)分析流程圖 / Analytical flow chart of elements (Heavy metal included)

根據以下的流程圖之條件,樣品已完全溶解。

These samples were dissolved totally by pre-conditioning method according to below flow chart.

【參考方法/Reference method: US EPA 3051A、US EPA 3052】



* US EPA 3051A 方法未添加氫氟酸 / US EPA 3051A method does not add HF.

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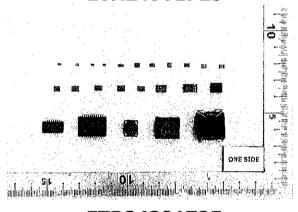
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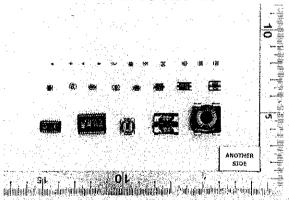
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* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)

ETR24301725



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** 報告結尾 (End of Report) **

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